New Jersey Semi-Conductor Products, Inc.

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# *RFL1P08, RFL1P10*

# 1A, -80V and -100V, 3.65 Ohm, P-Channel Power MOSFETs

### Features

- 1A, -80V and -100V
- r<sub>DS(ON)</sub> = 3.65Ω
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Majority Carrier Device

## **Ordering Information**

PART NUMBER	PACKAGE	BRAND
RFL1P08	TO-205AF	RFL1P08
RFL1P10	TO-205AF	RFL1P10

NOTE: When ordering, include the entire part number.

# Packaging

Description

These are P-Channel enhancement mode silicon gate power field effect transistors designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

# Symbol



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NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

# **Quality Semi-Conductors**

#### Absolute Maximum Ratings $T_C = 25^{\circ}C$ , Unless Otherwise Specified

	RFL1P08	RFL1P10	UNITS
Drain to Source Voltage (Note 1)	-80	-100	V
Drain to Gate Voltage (R <sub>GS</sub> = 20KΩ) (Note 1)	-80	-100	V
Continuous Drain CurrentI <sub>D</sub>	1	1	А
Pulsed Drain Current (Note 3)	5	5	А
Gate to Source VoltageV <sub>GS</sub>	±20	±20	V
Maximum Power Dissipation	8.33	8.33	W
Linear Derating Factor	0.0667	0.0667	W/ <sup>o</sup> C
Operating and Storage Temperature	-55 to 150	-55 to 150	°C
Maximum Temperature for Soldering			_
Leads at 0.063in (1.6mm) from Case for 10s	300	300	°C

AUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1.  $T_{\rm d}$  = 25°C to 125°C.

#### **Electrical Specifications** $T_C = 25^{\circ}C$ , Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	MAX	UNITS
Drain to Source Breakdown Voltage RFL1P08	BV <sub>DSS</sub>	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0	-80	-	-	v
RFL1P10			-100			
Gate to Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$	-2	-	-4	V
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = Rated BV <sub>DSS,</sub> V <sub>GS</sub> = 0V	-	-	-1	μΑ
		$V_{DS} = 0.8 \text{ x Rated } BV_{DSS}, V_{GS} = 0,$ $T_{C} = 125^{\circ}C$			25	μA
Gate to Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0	-	-	±100	nA
Drain to Source On-Voltage (Note 2)	V <sub>DS(ON)</sub>	I <sub>D</sub> = 1A, V <sub>GS</sub> = -10V	-	-	-3.65	V
Drain to Source On Resistance (Note 2)	「DS(ON)	I <sub>D</sub> = 1A, V <sub>GS</sub> = -10V (Figures 6, 7)	-	-	3.65	Ω
Turn-On Delay Time	<sup>t</sup> d(ON)	$      I_D \approx 1A, V_{DD} \approx -50V \\       R_G = 50\Omega \\       V_{GS} = -10V \\       R_L = 47\Omega \\       (Figures 10, 11, 12) $	-	7	25	ns
Rise Time	t <sub>r</sub>		-	15	45	ns
Turn-Off Delay Time	td(OFF)		-	14	45	ns
Fall Time	t <sub>f</sub>		-	11	25	ns
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = -25V f = 1MHz (Figure 9)	-	-	150	pF
Output Capacitance	C <sub>OSS</sub>		-	-	80	pF
Reverse-Transfer Capacitance	C <sub>RSS</sub>		-	-	30	pF
Thermal Resistance Junction to Case	R <sub>θJC</sub>		-	-	15	°C/W

#### **Source to Drain Diode Specifications**

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	MAX	UNITS
Source to Drain Diode Voltage (Note 2)	V <sub>SD</sub>	I <sub>SD</sub> = -1A	-	-	-1.4	V
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>SD</sub> = -1A, dI <sub>SD</sub> /dt = 50A/μs	-	135	-	ns

NOTES:

2. Pulse test: pulse width  $\leq 300 \mu s$  maximum, duty cycle  $\leq 2\%.$ 

3. Repetitive rating: pulse width limited by mazimum junction temperature.